Applicant(s) Application No. KURITA ET AL. 10/645,911 Notice of Allowability Examiner Art Unit Michael Kornakov -- The MAILING DATE of this communication appears on the cover sheet with the correspondence address--All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308. 1. This communication is responsive to 12/04/2006. 2. The allowed claim(s) is/are 1-5. 3. Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) 🖾 Ail b) Some\* c) None of the: 1. \( \subseteq \text{ Certified copies of the priority documents have been received.} \) 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)). \* Certified copies not received: \_\_\_\_\_. Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application. THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. 4. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient. 5. CORRECTED DRAWINGS (as "replacement sheets") must be submitted. (a) Including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d). 6. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL. Attachment(s) 1. Notice of References Cited (PTO-892) 5. Notice of Informal Patent Application 6. Interview Summary (PTO-413). 2. Notice of Draftperson's Patent Drawing Review (PTO-948) Paper No./Mail Date 7. Examiner's Amendment/Comment 3. Information Disclosure Statements (PTO/SB/08). Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit 8. X Examiner's Statement of Reasons for Allowance of Biological Material Other \_\_\_\_

Application/Control Number: 10/645,911

Art Unit: 1746

## **EXAMINER'S COMMENTS/REASONS FOR ALLOWANCE**

## Continued Examination Under 37 CFR 1.114

- 1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 12/04/2006 has been entered.
- 2. Claim 1 is amended to emphasize the step of oxidizing a silicon wafer annealed under an environment of hydrogen gas with ozonized water. Claims 1-5 are currently examined on the merits.
- 3. Claims 1-5 are allowed over the prior art of record.
- 4. The following is an examiner's statement of reasons for allowance: The closest prior art of record are Nakajima (U.S. 2002/0173085) and Mayusumi et al (U.S. 6,323,140).

Nakajima discloses a method for cleaning a silicon wafer wherein the steps of ozone/water cleaning and hydrofluoric acid cleaning are performed as pre-processes of the laser annealing. Nakajima fails to anticipate or suggest fairly a method with the claimed order of steps, wherein a step of oxidizing a silicon wafer with ozonized water is performed after annealing the wafer under an environment of hydrogen gas, and wherein a step of oxidizing the silicon wafer with ozonized water is a final cleaning step. The necessity of such order of steps is shown on this record.

Application/Control Number: 10/645,911

Art Unit: 1746

Mayusumi teaches a method of manufacturing semiconductor wafer, which includes treatment with ozone containing ultra-pure water, treatment with dilute HF solution, oxidation treatment with aqueous solution of ozone, followed by annealing in the presence of hydrogen, thus removing oxide film from the wafer surface. Mayusumi fails to anticipate or suggest fairly the wafer processing with the order of steps as instantly recited, wherein oxidizing the silicon wafer with ozonized water is a final cleaning step, the necessity of which is shown on this record.

No other prior art that anticipates or suggests fairly the instant claims has been located as of the date of this office action. Therefore, claims 1-5 are allowed over the prior art of record.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Michael Kornakov whose telephone number is (571) 272-1303. The examiner can normally be reached on 9:00am - 5:30pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Michael Barr can be reached on (571) 272-1414. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Application/Control Number: 10/645,911 Page 4

Art Unit: 1746

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

M. Koon A Coon Michael Kornakov Primary Examiner Art Unit 1746

02/12/2007